

Notice of References Cited	Application/Control No. 10/572,089		Applicant(s)/Patent Under Reexamination LE NAOUR ET AL.	
	Examiner Bobbak Safaipoor		Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,111,474 A	08-2000	Nibe, Masayuki	333/26
*	B	US-2003/0083034 A1	05-2003	Motoyama, Koji	455/323
*	C	US-2003/0152140 A1	08-2003	Antoniak, Michael	375/219
*	D	US-2003/0224801 A1	12-2003	Lovberg et al.	455/454
*	E	US-2004/0043743 A1	03-2004	Rzyski et al.	455/324
*	F	US-2004/0072550 A1	04-2004	Motoyama, Koji	455/323
*	G	US-2004/0203337 A1	10-2004	Ammar, Danny F.	455/003.02
*	H	US-2004/0203528 A1	10-2004	Ammar et al.	455/090.3
*	I	US-2005/0042993 A1	02-2005	Cremin et al.	455/118
*	J	US-6,987,960 B2	01-2006	Kashima, Yukihiro	455/318
*	K	US-7,065,326 B2	06-2006	Lovberg et al.	455/77
*	L	US-7,177,618 B2	02-2007	Motoyama, Koji	455/323
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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